

Application No.	Applicant(s)	
09/671,354	OKUMURA ET AL.	
Examiner	Art Unit	
Toan Ton	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	106,122	7/19/2004	TTON	
	113,138			
430	7			
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
349	106,122	7/22/2004	TTON	
	113,138			
430	7	-		
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SEARCH (INCLUDING SEAR		·)
	DATE	EXMR
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